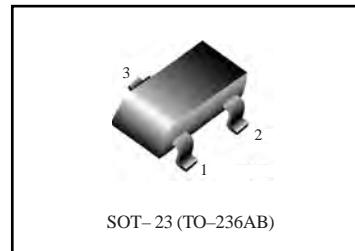


Small Signal MOSFET 380 mAmps, 60 Volts

N-Channel SOT-23

Features

- ESD Protected
- Low R_{D(on)}
- Surface Mount Package
- This is a Pb-Free Device
- We declare that the material of product are Halogen Free and compliance with RoHS requirements.
- AEC-Q101 qualified



Applications

- Low Side Load Switch
- Level Shift Circuits
- DC-DC Converter
- Portable Applications i.e. DSC, PDA, Cell Phone, etc.

MAXIMUM RATINGS (T_J = 25°C unless otherwise stated)

Rating	Symbol	Value	Unit
Drain-to-Source Voltage	V _{DSS}	60	V
Gate-to-Source Voltage	V _{GS}	±20	V
Drain Current (Note 1) Steady State	I _D	320 230	mA
T _A = 25°C T _A = 85°C			
s 5 < t T _A = 25°C T _A = 85°C		380 270	
Power Dissipation (Note 1) Steady State t < 5 s	P _D	300 420	mW
Pulsed Drain Current (t _p = 10 μs)	I _{DM}	1.5	A
Operating Junction and Storage Temperature Range	T _J , T _{STG}	-55 to +150	°C
Source Current (Body Diode)	I _S	300	mA
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)	T _L	260	°C
Gate-Source ESD Rating (HBM, Method 3015)	ESD	2000	V

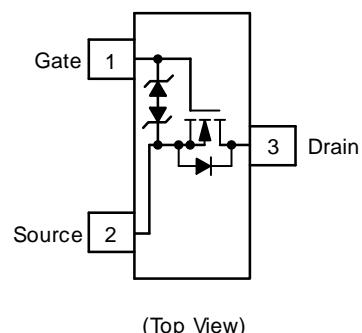
Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

THERMAL CHARACTERISTICS

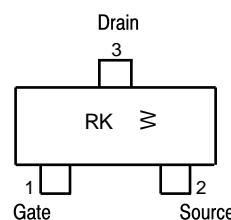
Characteristic	Symbol	Max	Unit
Junction-to-Ambient - Steady State (Note 1)	R _{θJA}	417	°C/W
Junction-to-Ambient - t ≤ 5 s (Note 1)	R _{θJA}	300	

1. Surface-mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [1 oz] including traces)

Simplified Schematic



MARKING DIAGRAM & PIN ASSIGNMENT



RK ≥
RK = Device Code
W = Month Code

ORDERING INFORMATION

Device	Marking	Shipping
FTK7002K	RK	3000 Tape & Reel



FTK7002K

ELECTRICAL CHARACTERISTICS ($T_J = 25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Test Condition	Min	Typ	Max	Units
OFF CHARACTERISTICS						
Drain-to-Source Breakdown Voltage	$V_{(\text{BR})\text{DSS}}$	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	60			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	$V_{(\text{BR})\text{DSS}}/T_J$			71		$\text{mV}/^\circ\text{C}$
Zero Gate Voltage Drain Current	I_{DSS}	$V_{GS} = 0 \text{ V}, V_{DS} = 60 \text{ V}$			1	μA
		$T_J = 25^\circ\text{C}$			500	
		$V_{GS} = 0 \text{ V}, V_{DS} = 50 \text{ V}$			100	nA
Gate-to-Source Leakage Current	I_{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 10	μA

ON CHARACTERISTICS (Note 2)

Gate Threshold Voltage	$V_{GS(\text{TH})}$	$V_{GS} = V_{DS}, I_D = 250 \mu\text{A}$	1.0		2.5	V
Negative Threshold Temperature Coefficient	$V_{GS(\text{TH})}/T_J$			4.0		$\text{mV}/^\circ\text{C}$
Drain-to-Source On Resistance	$R_{DS(\text{on})}$	$V_{GS} = 10 \text{ V}, I_D = 500 \text{ mA}$			2.3	Ω
		$V_{GS} = 5.0 \text{ V}, I_D = 50 \text{ mA}$			2.7	
		$V_{GS} = 3.3 \text{ V}, I_D = 10 \text{ mA}$			10	
Forward Transconductance	g_{FS}	$V_{DS} = 5 \text{ V}, I_D = 200 \text{ mA}$	80			mS

CHARGES AND CAPACITANCES

Input Capacitance	C_{ISS}	$V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}, V_{DS} = 25 \text{ V}$		34		pF
Output Capacitance	C_{OSS}			3		
Reverse Transfer Capacitance	C_{RSS}			2.2		
Total Gate Charge	$Q_{G(\text{TOT})}$	$V_{GS} = 4.5 \text{ V}, V_{DS} = 10 \text{ V}; I_D = 500 \text{ mA}$		0.71		nC
Threshold Gate Charge	$Q_{G(\text{TH})}$			0.1		
Gate-to-Source Charge	Q_{GS}			0.32		
Gate-to-Drain Charge	Q_{GD}			0.16		

SWITCHING CHARACTERISTICS, $V_{GS} = V$ (Note 3)

Turn-On Delay Time	$t_{d(\text{ON})}$	$V_{DS} = 10 \text{ V}, V_{\text{GEN}} = 10 \text{ V}, I_D = 500 \text{ mA}$		3.8		ns
Rise Time	t_r			3.4		
Turn-Off Delay Time	$t_{d(\text{OFF})}$			19		
Fall Time	t_f			12		

DRAIN-SOURCE DIODE CHARACTERISTICS

Forward Diode Voltage	V_{SD}	$V_{GS} = 0 \text{ V}, I_S = 115 \text{ mA}$	$T_J = 25^\circ\text{C}$		1.4	V
			$T_J = 85^\circ\text{C}$		0.7	

2. Pulse Test: pulse width $\leq 300 \mu\text{s}$, duty cycle $\leq 2\%$

3. Switching characteristics are independent of operating junction temperatures

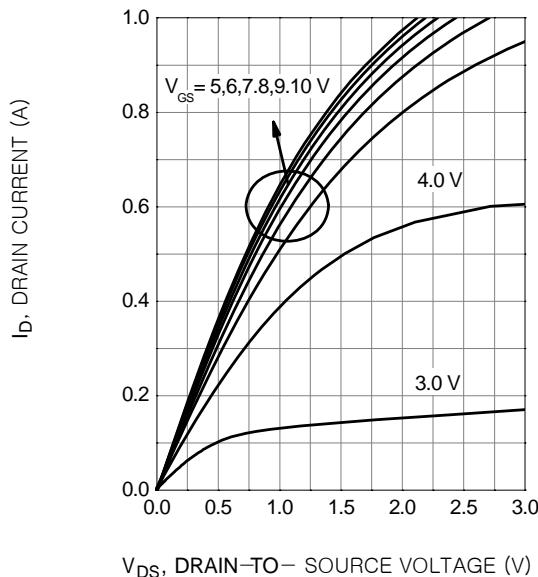
TYPICAL ELECTRICAL CHARACTERISTICS


Figure 1. On-Region Characteristics

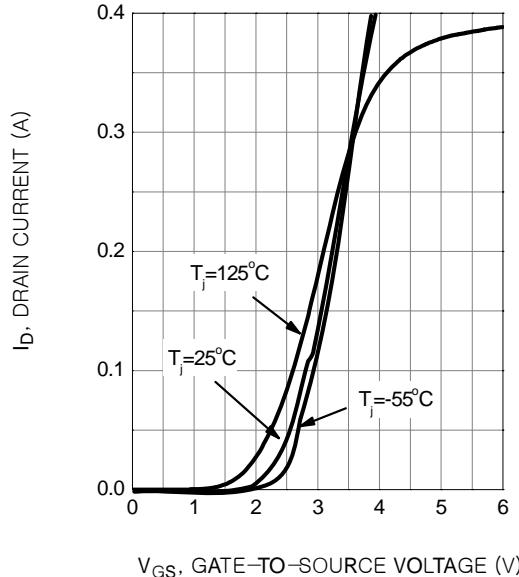


Figure 2. Transfer Characteristics

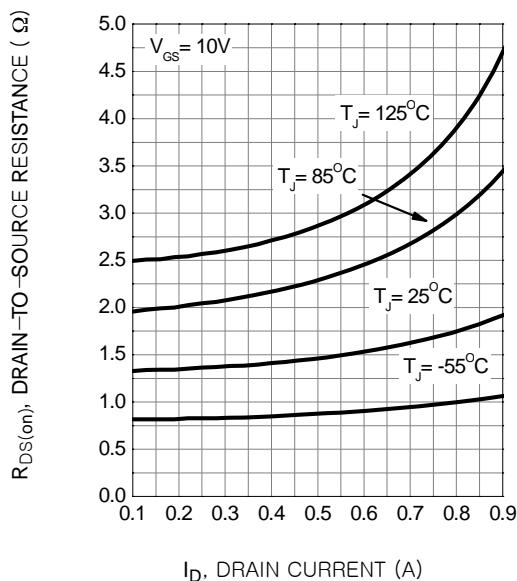


Figure 3. On-Resistance vs. Drain Current and Temperature

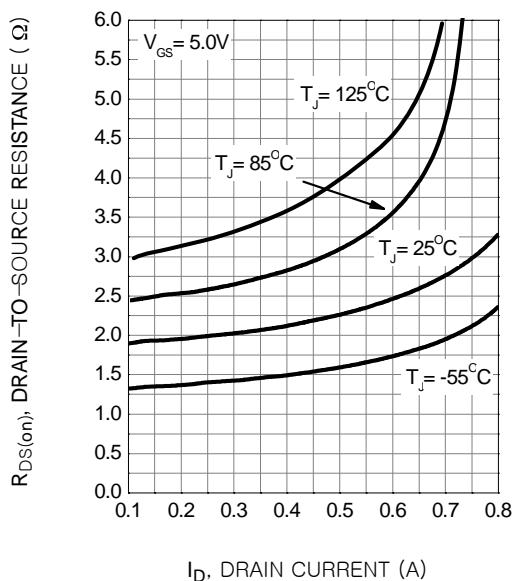


Figure 4. On-Resistance vs. Drain Current and Temperature

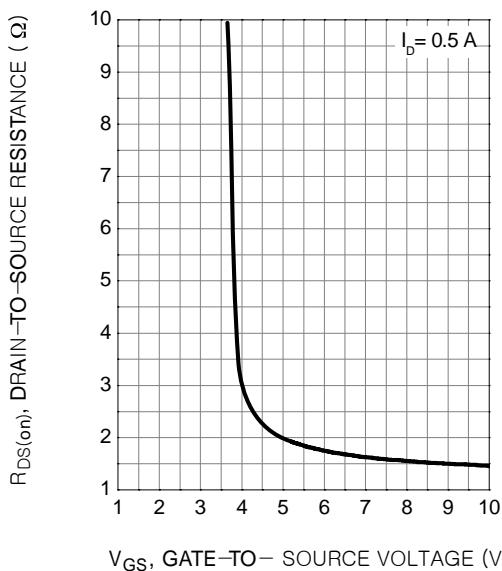
TYPICAL ELECTRICAL CHARACTERISTICS


Figure 5. On-Resistance vs. Gate-to-Source Voltage

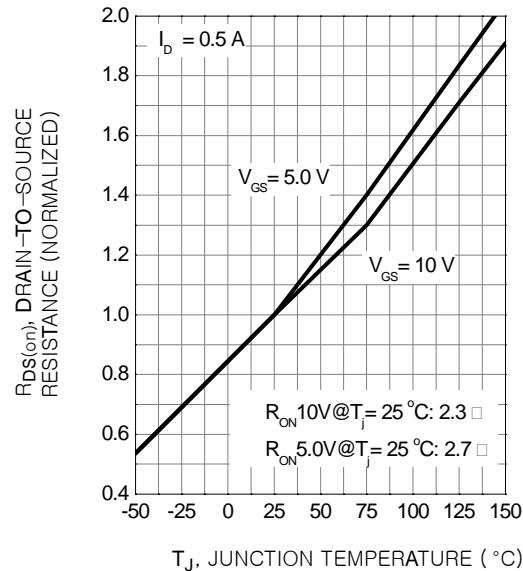


Figure 6. On-Resistance Variation with Temperature

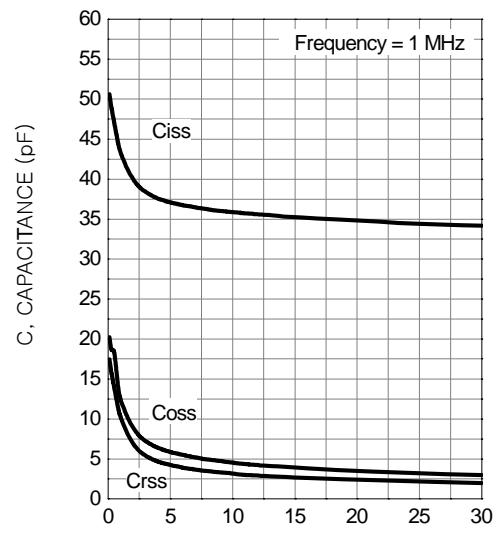


Figure 7. Capacitance Variation

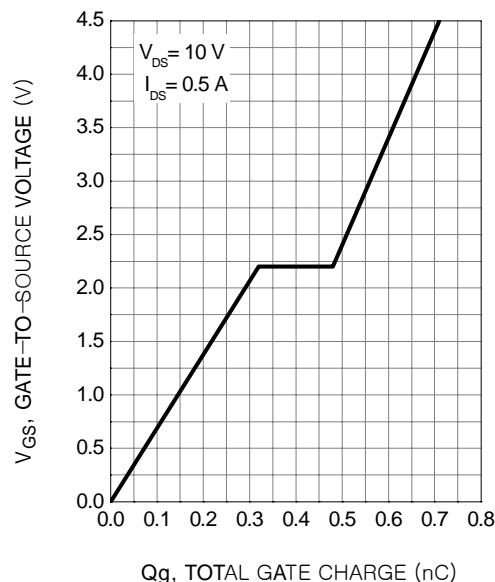
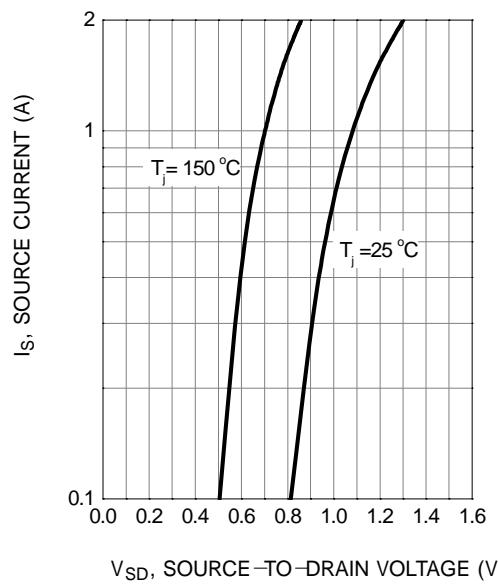
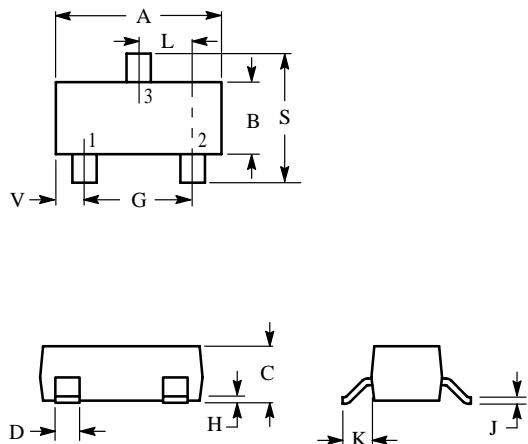


Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

TYPICAL ELECTRICAL CHARACTERISTICS**Figure 9. Diode Forward Voltage vs. Current**

SOT -23
NOTES:

1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M,1982
2. CONTROLLING DIMENSION: INCH.



DIM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	0.1102	0.1197	2.80	3.04
B	0.0472	0.0551	1.20	1.40
C	0.0350	0.0440	0.89	1.11
D	0.0150	0.0200	0.37	0.50
G	0.0701	0.0807	1.78	2.04
H	0.0005	0.0040	0.013	0.100
J	0.0034	0.0070	0.085	0.177
K	0.0140	0.0285	0.35	0.69
L	0.0350	0.0401	0.89	1.02
S	0.0830	0.1039	2.10	2.64
V	0.0177	0.0236	0.45	0.60

